Search Notes			

Applic	ation/Control No.		Applicant(s)/Patent under Reexamination	
10/662	2,436	LIM ET AL.		
Exami		Art Unit		
Toan	Ton	2871		

	SEARCHED			
Class	Subclass	Date	Examiner	
349	106	6/29/2005	TTON	
	44`			
	139			
	110		•	
257	59			
	72			
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
349	44,106	6/29/2005	TTON
	110,139		
257	59,72		

SEARCH I (INCLUDING SEAR			')
		DATE	EXMR
EAST liquid crystal thin film transistor black matrix/mask drain/source electrode data/source line/bus color connect\$ pixel	6.	/29/2005	TTON
hole,aperture,slit,opening ellectrodeposit\$			
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